

Information Disclosure Statement

USSN 10/789,261

July 23, 2004

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Form PTO-1449 (Modified)	ATTY DOCKET NO. B-3948DIV 621654-4	U.S. SERIAL NO. 10/789,261
LIST OF PATENTS AND PUBLICATIONS STATEMENT	APPLICANTS James P. Baukus, et al.	
	FILING DATE February 26, 2004	GROUP not yet assigned

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	ISSUE DATE	NAME	CLASS	SUB- CLASS	FILING DATE or 102(e) DATE IF APPROPRIATE
JW	5,834,356	11/1998	Bothra et al.	438	384	
	5,998,257	12/1999	Lane et al.	438	253	
	6,740,942 B2	5/2004	Baukus et al.	257	406	
	10/828,022		Chow et al.	—	—	4/19/2004
	10/881,286		Chow et al.	—	—	6/29/2004

FOREIGN PATENT DOCUMENTS

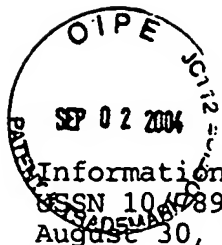
DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER JOSEPH AN VYEN	DATE CONSIDERED 2/23/05
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August 30, 2004

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LIST OF PATENTS AND PUBLICATIONS STATEMENT	APPLICANTS James P. Baukus, et al.	
	FILING DATE February 26, 2004	GROUP 2811

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	ISSUE DATE	NAME	CLASS	SUB- CLASS	FILING DATE or 102(e) DATE IF APPROPRIATE
JN	4,530,150	7/1985	Shirato	29	576 B	
	5,073,812	12/1991	Shimura	357	34	
	6,153,484	11/2000	Donaton et al.	438	301	
	6,261,912 B1	7/2001	Hsiao et al.	438	301	

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	DOCUMENT NUMBER	PUBLICATION DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO
JN	02-188944	7/1990	JP	—	—	abstract

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER JOSEPH N. RUYEN	DATE CONSIDERED 2/23/05
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Form PTO-1449 (Modified)	ATTY DOCKET NO. B-3948DIV 621654-4	U.S. SERIAL NO. not yet assigned
LIST OF PATENTS AND PUBLICATIONS STATEMENT	APPLICANT(S) James P. BAUKUS, et al. 10/789261	
	FILING DATE concurrently herewith	GROUP 2815

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	ISSUE DATE	NAME	CLASS	SUB- CLASS	FILING DATE or 102(e) DATE IF APPROPRIATE
JN	3,673,471	6/72	Klein et al.	317	235 R	
	3,946,426	3/76	Sanders	357	71	
	4,017,888	4/77	Christie et al.	357	54	
	4,101,344	7/78	Kooi et al.	148	1.5	
	4,139,864	2/79	Schulman	358	188	
	4,164,461	8/79	Schilling	204	192 EC	
	4,196,443	4/80	Dingwall	357	68	
	4,267,578	5/81	Vetter	364	709	
	4,291,391	9/81	Chatterjee et al.	365	184	
	4,295,897	10/81	Tubbs et al.	148	1.5	
	4,314,268	2/82	Yoshioka et al.	357	68	
	4,317,273	3/82	Guterman et al.	29	571	
	4,322,736	3/82	Sasaki et al.	357	59	
	4,374,454	2/83	Jochems	29	571	
	4,409,434	10/83	Basset et al.	380	265	
	4,435,895	3/84	Parillo	29	571	
	4,471,376	3/84	Morcom et al.	357	71	
	4,581,628	4/86	Miyauchi et al.	357	71	
	4,583,011	4/86	Pechar	307	440	
	4,603,381	7/86	Guttag et al.	364	200	

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JN	4,623,255	11/86	Suszko	356	389	
	4,727,493	2/88	Taylor, Sr.	364	490	
	4,766,516	8/88	Ozdemir et al.	361	380	
	4,799,096	1/89	Koepppe	357	42	
	4,821,085	4/89	Haken et al.	357	67	
	4,830,974	5/89	Chang et al.	437	34	
	4,939,567	7/90	Kenney	257	383	
	4,975,756	12/90	Haken et al.	357	4.1	
	4,998,151	3/91	Korman et al.	257	328	
	4,962,484	10/90	Takeshima et al.	365	226	
	5,030,796	7/91	Swanson et al.	174	52.2	
	5,050,123	9/91	Castro	365	53	
	5,061,978	10/91	Mizutani et al.	357	30	
	5,065,208	11/91	Shah et al.	357	34	
	5,068,697	11/91	Noda et al.	357	23.5	
	5,070,378	12/91	Yamagata	357	23.5	
	5,101,121	3/92	Sourgen	307	465	
	5,117,276	5/92	Thomas et al.	357	71	
	5,121,089	6/92	Larson et al.	333	107	
	5,121,186	6/92	Wong et al.	257	384	
	5,132,571	7/92	McCollum et al.	307	465.1	
	5,138,197	8/92	Kuwana	307	449	
	5,146,117	9/92	Larson	307	465	
	5,168,340	12/92	Nishimura	357	376	
	5,177,589	1/93	Kobayashi et al.	257	773	
	5,202,591	4/93	Walden	307	450	
	5,225,699	7/93	Nakamura	257	306	
	5,227,649	7/93	Chapman	257	204	
	5,231,299	7/93	Ning et al.	257	316	
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JN	5,308,682	5/94	Morikawa	428	195	
	5,309,015	5/94	Kuwata et al.	257	659	
	5,317,197	5/94	Roberts	257	401	
	5,336,624	8/94	Walden	437	34	
	5,341,013	8/94	Koyanagi et al.	257	368	
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	5,369,299	11/94	Byrne et al.	257	638	
	5,371,390	12/94	Mohsen	257	209	
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	5,384,472	1/95	Yin	257	204	
	5,384,475	1/1995	Yahata	257	314	
	5,399,441	3/95	Bearinger et al.	428	689	
	5,404,040	4/95	Hshieh et al.	257	341	
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	5,441,902	8/95	Hsieh et al.	437	34	
	5,468,990	11/95	Daum	257	632	
	5,475,251	12/95	Kuo et al.	257	316	
	5,506,806	4/96	Fukushima	365	195	
	5,531,018	7/96	Saia et al.	29	622	
	5,539,224	7/96	Ema	257	211	
	5,541,614	7/96	Lam et al.	343	792.5	
	5,571,735	11/96	Mogami et al.	437	41	
	5,576,988	11/96	Kuo et al.	365	185.04	
	5,611,940	3/97	Zettler	73	514.16	
	5,638,946	6/97	Zavracky	200	181	
	5,677,557	10/97	Wuu et al.	257	382	
	5,679,595	10/97	Chen et al.	437	52	
	5,719,422	2/98	Burr et al.	257	336	
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JN	5,721,150	2/98	Pasch	437	46	
	5,783,375	7/98	Twist	430	414	
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	5,920,097	7/99	Horne	257	368	
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JN	10/132,523		Clark, Jr. et al.	—	—	4/24/2002
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EXAMINER	DATE CONSIDERED
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